

1200 V XPT IGBT

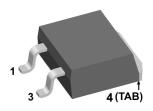
I _{C25} 38 A

 $V_{CE(sat)}$ = 1.8 V

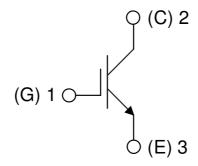
Single IGBT

Part number

IXA20I1200PZ



Backside: collector



Features / Advantages:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 µsec.
- very low gate charge
- low EMI
- square RBSOA @ 3x lc
- Thin wafer technology combined with the XPT design results in a competitive low VCE(sat)

Applications:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies
- Inductive heating, cookers
- Pumps, Fans

Package: TO-263 (D2Pak-HV)

- Industry standard outline
- RoHS compliant
- Epoxy meets UL 94V-0

Terms _Conditions of usage:

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales office.

Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office.

Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

to perform joint risk and quality assessments;
the conclusion of quality agreements;

- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

IXYS reserves the right to change limits, conditions and dimensions.

Data according to IEC 60747 and per semiconductor unless otherwise specified

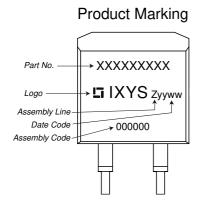
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IGBT	BT			Ratings				
Symbol	Definition		Conditions		min.	typ.	max.	Unit
V _{CES}	collector emitter voltage			$T_{VJ} = 25^{\circ}C$			1200	V
V _{GES}	max. DC gate voltage						±20	V
V_{GEM}	max. transient gate emitter voltage						±30	V
I _{C25}	collector current			$T_{C} = 25^{\circ}C$			38	Α
I _{C80}				$T_{c} = 80^{\circ}C$			22	Α
P _{tot}	total power dissipation			$T_{C} = 25^{\circ}C$			165	W
V _{CE(sat)}	collector emitter saturation voltage		$I_{C} = 15A; V_{GE} = 15 V$	$T_{VJ} = 25^{\circ}C$		1.8	2.1	V
				$T_{VJ} = 125 ^{\circ}\text{C}$		2.1		V
$V_{GE(th)}$	gate emitter threshold voltage		$I_C = 0.6 \text{ mA}; V_{GE} = V_{CE}$	$T_{VJ} = 25^{\circ}C$	5.4	5.9	6.5	V
I _{CES}	collector emitter leakage current		$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^{\circ}C$			0.1	mA
				$T_{VJ} = 125 ^{\circ}\text{C}$		0.1		mΑ
I _{GES}	gate emitter leakage current		$V_{GE} = \pm 20 \text{ V}$				500	nΑ
$Q_{G(on)}$	total gate charge		$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_{C} =$	15 A		47		nC
t _{d(on)}	turn-on delay time	7				48		ns
t _r	current rise time		industive lead	T 105.00		30		ns
$\mathbf{t}_{d(off)}$	turn-off delay time		inductive load	$T_{VJ} = 125 ^{\circ}\text{C}$		230		ns
\mathbf{t}_{f}	current fall time		$V_{CE} = 600 V; I_{C} = 15 A$ $V_{GE} = \pm 15 V; R_{G} = 56 \Omega$			350		ns
E_{on}	turn-on energy per pulse		$V_{GE} = \pm 15 \text{ V}, H_G = 50 \Omega$			1.6		mJ
E_{off}	turn-off energy per pulse	ノ				1.7		mJ
RBSOA	reverse bias safe operating area	7	$V_{GE} = \pm 15 \text{ V}; R_{G} = 56 \Omega$	T _{vJ} = 125°C				
I _{CM}		\int	$V_{CEmax} = 1200 V$				45	Α
SCSOA	short circuit safe operating area	7	V _{CEmax} = 1200 V					
tsc	short circuit duration	}	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V}$	$T_{VJ} = 125 ^{\circ}C$			10	μs
I _{sc}	short circuit current	J	$R_G = 56 \Omega$; non-repetitive			60		Α
R _{thJC}	thermal resistance junction to case						0.76	K/W
R _{thCH}	thermal resistance case to heatsink					0.25		K/W



Package TO-263 (D2Pak-HV)			Ratings			
Symbol	Definition Conditions		min.	typ.	max.	Unit
I _{RMS}	RMS current per terminal				35	Α
T _{VJ}	virtual junction temperature		-40		150	°C
T _{op}	operation temperature		-40		125	°C
T _{stg}	storage temperature		-40		150	°C
Weight				1.5		g
F _c	mounting force with clip		20		60	N
d _{Spp/App}	creepage distance on surface striking distance through ai	terminal to terminal	4.2			mm
$d_{\text{Spb/Apb}}$	creepage distance on surrace striking distance through a	terminal to backside	4.7			mm



Part description

I = IGBT X = XPT IGBT

A = Gen 1 / std

20 = Current Rating [A]

I = Single IGBT

1200 = Reverse Voltage [V] PZ = TO-263AB (D2Pak) (2HV)

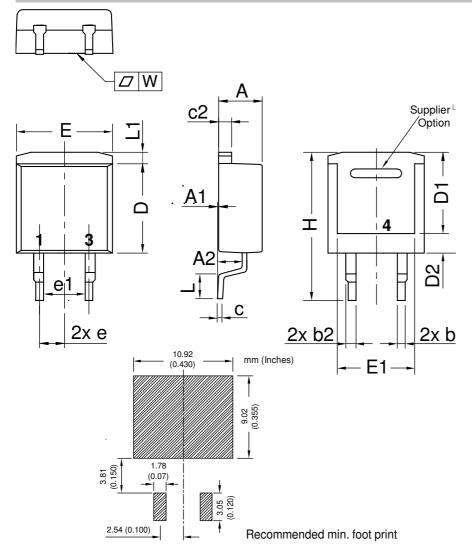
Ordering	Ordering Number	Marking on Product	Delivery Mode	Quantity	Code No.
Standard	IXA20I1200PZ	IXA20I1200PZ	Tape & Reel	800	518533

Similar Part	Package	Voltage class
IXA20I1200PZ	TO-220AB (3)	1200
IXA20IF1200HB	TO-247AD (3)	1200

Equiva	alent Circuits for Simulation	* on die level	T _{vJ} = 150 °C
$I \rightarrow V_0$	- R _o	IGBT	
V _{0 max}	threshold voltage	1.1	V
$R_{0 max}$	slope resistance *	86	$m\Omega$

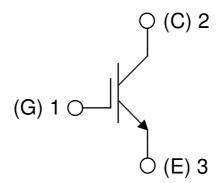


Outlines TO-263 (D2Pak-HV)



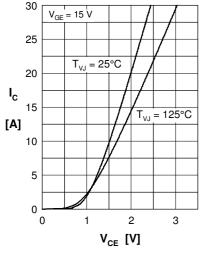
Dim.	Millimeter		Inches		
Diiii.	min	max	min	max	
Α	4.06	4.83	0.160	0.190	
A1	typ.	0.10	typ. 0.004		
A2	2.	41	0.095		
b	0.51	0.99	0.020	0.039	
b2	1.14	1.40	0.045	0.055	
С	0.40	0.74	0.016	0.029	
c2	1.14	1.40	0.045	0.055	
D	8.38	9.40	0.330	0.370	
D1	8.00	8.89	0.315	0.350	
D2	2.3		0.091		
Е	9.65	10.41	0.380	0.410	
E1	6.22	8.50	0.245	0.335	
е	2,54 BSC		0,100 BSC		
e1	4.28		0.169		
Н	14.61	15.88	0.575	0.625	
L	1.78	2.79	0.070	0.110	
L1	1.02	1.68	0.040	0.066	
W	typ. 0.02	0.040	typ. 0.0008	0.002	

All dimensions conform with and/or within JEDEC standard.





IGBT





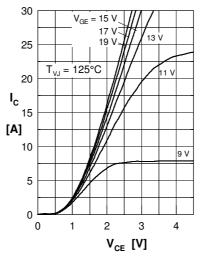


Fig. 2 Typ. output characteristics

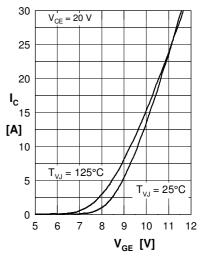


Fig. 3 Typ. transfer characteristics

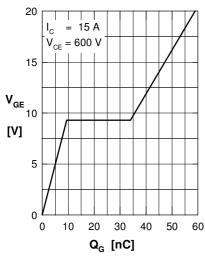


Fig. 4 Typ. turn-on gate charge

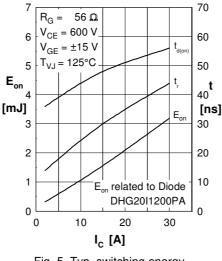


Fig. 5 Typ. switching energy vs. collector current

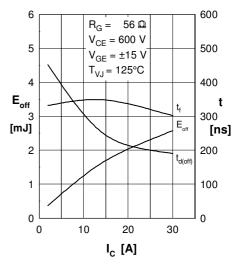


Fig. 6 Typ. switching energy vs. collector current

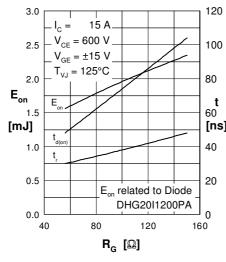


Fig. 7 Typ. switching energy vs. gate resistance

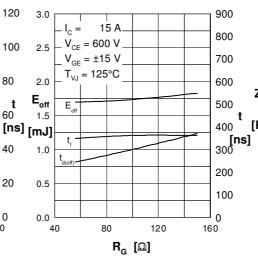


Fig. 8 Typ. switching energy vs. gate resistance

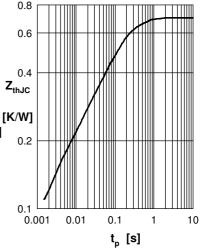


Fig. 9 Typ. transient thermal impedance junction to case